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The semiconductor operations of Hitachi and Mitsubishi Electric were transferred to Renesas Technology Corporation on April 1st 2003. These operations include microcomputer, logic, analog and discrete devices, and memory chips other than DRAMs (flash memory, SRAMs etc.) Accordingly, although Mitsubishi Electric, Mitsubishi Electric Corporation, Mitsubishi Semiconductors, and other Mitsubishi brand names are mentioned in the document, these names have in fact all been changed to Renesas Technology Corp. Thank you for your understanding. Except for our corporate trademark, logo and corporate statement, no changes whatsoever have been made to the contents of the document, and these changes do not constitute any alteration to the contents of the document itself.

Note: Mitsubishi Electric will continue the business operations of high frequency & optical devices and power devices.

Renesas Technology Corp. Customer Support Dept. April 1, 2003



DESCRIPTION

The M5M51008DP,FP,VP,RV,KV are a 1048576-bit CMOS static RAM organized as 131072 word by 8-bit which are fabricated using high-performance quadruple-polysilicon and double metal CMOS technology. The use of thin film transistor (TFT) load cells and CMOS periphery result in a high density and low power static RAM.

They are low standby current and low operation current and ideal

for the battery back-up application.

The M5M51008DVP,RV,KV are packaged in a 32-pin thin small outline package which is a high reliability and high density surface mount device(SMD). Two types of devices are available.

M5M51008DVP(normal lead bend type package),

M5M51008DRV(reverse lead bend type package). Using both types of devices, it becomes very easy to design a printed circuit board.

FEATURES

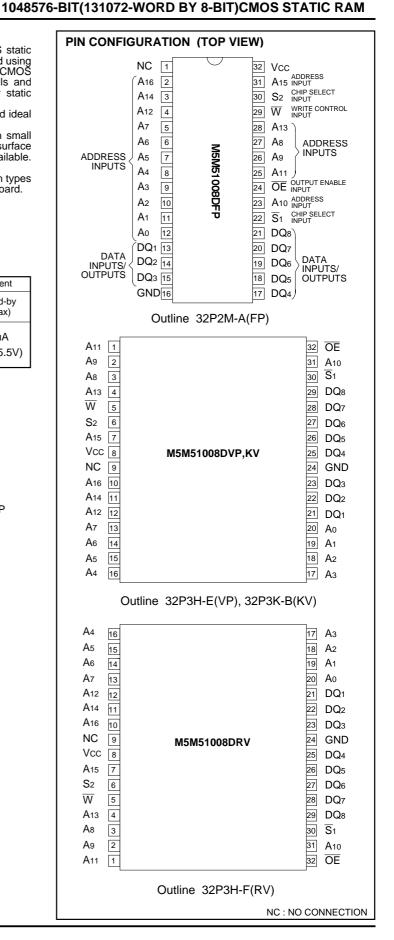
	Access	Power supply current				
Type name	time (max)	Active (1MHz) (max)	stand-by (max)			
M5M51008DFP,VP,RV,KV-55H	55ns	15mA	20μΑ			
M5M51008DFP,VP,RV,KV-70H	70ns	(1MHz)	(Vcc=5.5V)			

- Directly TTL compatible : All inputs and outputs
- Easy memory expansion and power down by S
 ¹
 1,S₂
- Data hold on +2V power supply
- Three-state outputs : OR tie capability
- OE prevents data contention in the I/O bus
- Common data I/O
- Package

M5M51008DFP	32pin	525mil SQP
		8 X 20 mm ² TSOP
M5M51008DKV	32pin	8 X 13.4 mm ² TSOP

APPLICATION

Small capacity memory units



1048576-BIT(131072-WORD BY 8-BIT)CMOS STATIC RAM

FUNCTION

The operation mode of the M5M51008D series are determined by a combination of the device control inputs $\overline{S}_1,S_2,\overline{W}$ and \overline{OE} .

Each mode is summarized in the function table.

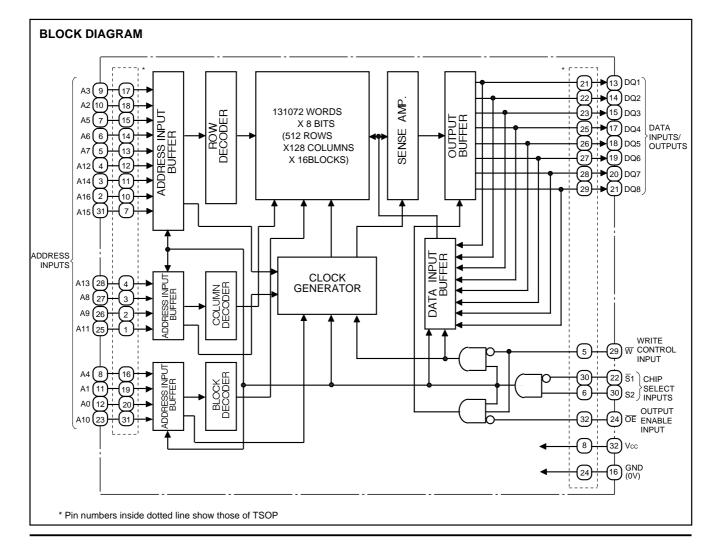
A write cycle is executed whenever the low level \overline{W} overlaps with the low level \overline{S}_1 and the high level S_2 . The address must be set up before the write cycle and must be stable during the entire cycle. The data is latched into a cell on the trailing edge of W,S1 or The data is latched into a cell off the trailing edge of W,S1 of S2,whichever occurs first,requiring the set-up and hold time relative to these edge to be maintained. The output enable input \overline{OE} directly controls the output stage. Setting the \overline{OE} at a high level, the output stage is in a high-impedance state, and the data bus contention problem in the write cycle is eliminated. A read cycle is executed by setting \overline{W} at a high level and \overline{OE} at a low level while $\overline{S1}$ and $\overline{S2}$ are in an active state($\overline{S1}$ =L,S2=H).

When setting \overline{S}_1 at a high level or S_2 at a low level, the chip are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by \$\overline{S}_1\$ and \$\overline{S}_2\$. The power supply current is reduced as low as the stand-by current which is specified as Icc3 or Icc4, and the memory data can be held at +2V power supply, enabling battery back-up operation during power failure or power-down operation in the nonselected mode.

FUNCTION TABLE

S ₁	S ₂	\overline{W}	ŌĒ	Mode	DQ	Icc
Х	L	Χ	Х	Non selection	High-impedance	Stand-by
Н	Х	Χ	Х	Non selection	High-impedance	Stand-by
L	Н	L	Χ	Write	Din	Active
L	Н	Н	L	Read	Dout	Active
L	Н	Н	Н		High-impedance	Active

Note 1: "H" and "L" in this table mean VIH and VIL, respectively. 2: "X" in this table should be "H" or "L".



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Unit
Vcc	Supply voltage		- 0.3*~7	V
VI	Input voltage	With respect to GND	- 0.3*~Vcc + 0.3	V
Vo	Output voltage		0~Vcc	V
P_d	Power dissipation	Ta=25°C	700	mW
T _{opr}	Operating temperature		0~70	°C
T _{stg}	Storage temperature		- 65~150	°C

^{* -3.0}V in case of AC (Pulse width 50ns)

DC ELECTRICAL CHARACTERISTICS (Ta=0~70°C, Vcc=5V±10%, unless otherwise noted)

Symbol	Parameter	Test conditions	Test conditions			Limits		Unit
Symbol	Falameter	1 CSt CONDITIONS		Min	Тур	Max	Offic	
VIH	High-level input voltage				2.2		Vcc + 0.3	V
VIL	Low-level input voltage				-0.3*		0.8	V
Vон	High-level output voltage	IOH= -1.0mA			2.4			V
VOIT	riigirieveroutput voitage	IoH= -0.1mA			Vcc - 0.5			V
Vol	Low-level output voltage	IoL=2mA					0.4	V
lı	Input current	Vi=0~Vcc					±1	μΑ
lo	Output current in off-state	S ₁ =ViH or S ₂ =ViL or OE=ViH Vi/O=0~VCC					±1	μΑ
		S ₁ 0.2V, S ₂ VCC–0.2V other inputs 0.2V or VCC–0.2V		55ns		39	80	
ICC1	Active supply current (AC, MOS level)			70ns		34	70	mA
	,	Output-open(duty 100%)		1MHz		4	15	
	A .:	S1=VIL,S2=VIH,		55ns		42	85	
ICC2	Active supply current (AC, TTL level)	other inputs=ViH or ViL		70ns		37	70	mA
		Output-open(duty 100%)		1MHz		5	15	
		1) S2 0.2V, other inputs=0~Vcc		~25°C			2	
Іссз	Stand-by current	2) \$1 Vcc-0.2V,	-H	~40°C			6	μA
		S2 Vcc-0.2V, other inputs=0~Vcc		~70°C			20	
ICC4	Stand-by current	S _{1=VIH} or S _{2=VIL} , other inputs=0~Vcc					3	mA

^{* -3.0}V in case of AC (Pulse width 50ns)

CAPACITANCE (Ta=0~70°C, Vcc=5V±10% unless otherwise noted)

Cumbal	Parameter		Test conditions				
Symbol			Test conditions	Min	Тур	Max	Unit
Cı	Input capacitance	FP,VP,RV,KV	VI=GND, VI=25mVrms, f=1MHz			8	pF
Со	Output capacitance	FP,VP,RV,KV	Vo=GND,Vo=25mVrms, f=1MHz			10	pF

Note 3: Direction for current flowing into an IC is positive (no mark).



^{4:} Typical value is Vcc = 5V, Ta = 25°C

1048576-BIT(131072-WORD BY 8-BIT)CMOS STATIC RAM

AC ELECTRICAL CHARACTERISTICS (Ta=0~70°C, 5V±10% unless otherwise noted)

(1) MEASUREMENT CONDITIONS

Input pulse level ······ VIH=2.4V, VIL=0.6V (-70H)

VIH=3.0V,VIL=0.0V (-55H)

Input rise and fall time 5ns

Reference level ·······VoH=VoL=1.5V

Output loads \cdots Fig.1, CL=100pF (-70H) CL=30pF (-55H)

CL=50F (for ten,tdis)

Transition is measured ± 500mV from steady

state voltage. (for ten,tdis)

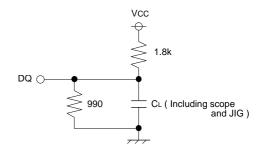


Fig.1 Output load

(2) READ CYCLE

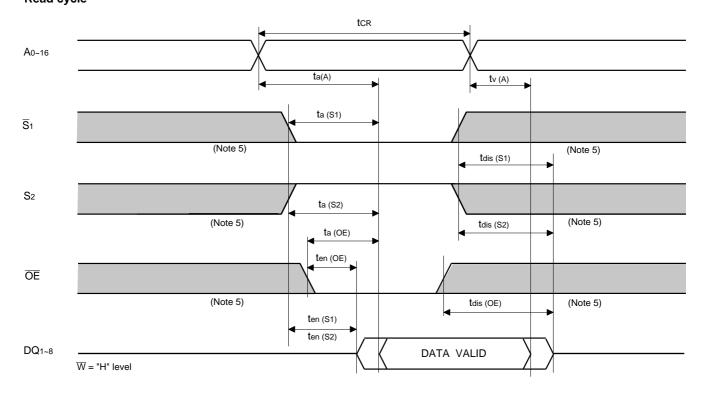
	Parameter					
Symbol		-5	5H	-70H		Unit
		Min	Max	Min	Max	
tcr	Read cycle time	55		70		ns
ta(A)	Address access time		55		70	ns
ta(S1)	Chip select 1 access time		55		70	ns
ta(S2)	Chip select 2 access time		55		70	ns
ta(OE)	Output enable access time		30		35	ns
tdis(S1)	Output disable time after S ₁ high		20		25	ns
tdis(S2)	Output disable time after S2 low		20		25	ns
tdis(OE)	Output disable time after OE high		20		25	ns
ten(S1)	Output enable time after \overline{S}_1 low	5		10		ns
ten(S2)	Output enable time after S ₂ high	5		10		ns
ten(OE)	Output enable time after OE low	5		5		ns
tV(A)	Data valid time after address	5		10		ns

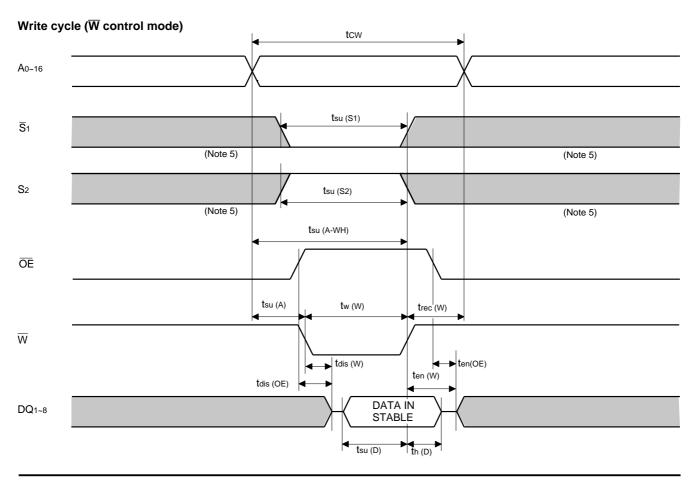
(3) WRITE CYCLE

			Limits					
Symbol	Parameter	-5	5H	-70H		Unit		
		Min	Max	Min	Max			
tcw	Write cycle time	55		70		ns		
tw(W)	Write pulse width	45		50		ns		
tsu(A)	Address setup time	0		0		ns		
tsu(A-WH)	Address setup time with respect to $\overline{\mathbb{W}}$	50		55		ns		
tsu(S1)	Chip select 1 setup time	50		55		ns		
tsu(S2)	Chip select 2 setup time	50		55		ns		
tsu(D)	Data setup time	25		30		ns		
th(D)	Data hold time	0		0		ns		
trec(W)	Write recovery time	0		0		ns		
tdis(W)	Output disable time from \overline{W} low		20		25	ns		
tdis(OE)	Output disable time from OE high		20		25	ns		
ten(W)	Output enable time from W high	5		5		ns		
ten(OE)	Output enable time from OE low	5		5		ns		



(4) TIMING DIAGRAMS Read cycle



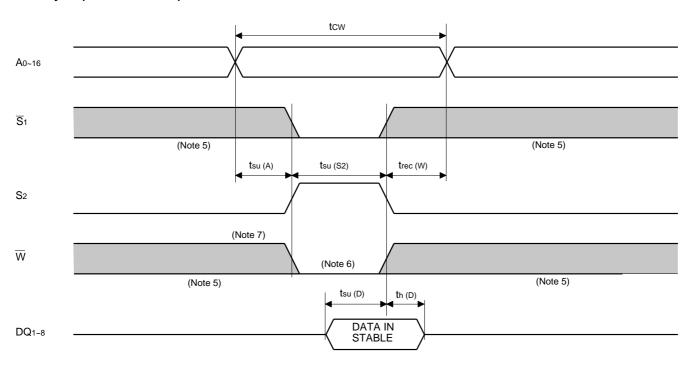




M5M51008DFP, VP, RV, KV, KR -55H, -70H 1048576-BIT(131072-WORD BY 8-BIT)CMOS STATIC RAM

Write cycle (\$\overline{S}_1\$ control mode) tcw A0~16 tsu (A) **t**su (S1) trec (W) \overline{S}_1 S₂ (Note 5) (Note 5) (Note 7) $\overline{\mathsf{W}}$ (Note 6) (Note 5) (Note 5) th (D) tsu (D) DATA IN STABLE DQ1~8

Write cycle (S2 control mode)



- Note 5: Hatching indicates the state is "don't care".

 6: Writing is executed while S₂ high overlaps \overline{S}_1 and \overline{W} low.

 7: When the falling edge of \overline{W} is simultaneously or prior to the falling edge of \overline{S}_1 or rising edge of S₂, the outputs are maintained in the high impedance state.
 - 8: Don't apply inverted phase signal externally when DQ pin is output mode.



1048576-BIT(131072-WORD BY 8-BIT)CMOS STATIC RAM

POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS (Ta=0~70°C, unless otherwise noted)

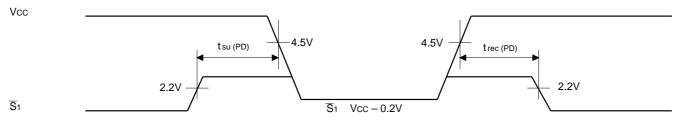
Symbol	Parameter	Test conditions				Limits		Unit
Symbol	Faiametei				Min	Тур	Max	Unit
VCC (PD)	Power down supply voltage				2.0			V
VI (S1)	Chip select input \$\overline{S}_1\$	2.2V Vcc(PD)			2.2			V
V1 (S1)	Criip select iriput 51	2V Vcc(PD) 2.2V				Vcc(PD)		V
\/ı (00)	Chin calcation at Ca	4.5V Vcc(PD)					0.8	V
VI (S2)	Chip select input S2	Vcc(PD)<4.5V					0.2	V
		Vcc = 3V		~25°C			1	
ICC (PD)	Power down supply current	1) S ₂ 0.2V, other inputs = 0~3V 2) \$\overline{S}_1\$ Vcc-0.2V, S ₂ Vcc-0.2V	-Н	~40°C			3	μΑ
		other inputs = 0~3V		~70°C			10	

(2) TIMING REQUIREMENTS (Ta=0~70°C, unless otherwise noted)

Symbol	Parameter	Test conditions		I I a it		
			Min	Тур	Max	Unit
tsu (PD)	Power down set up time		0			ns
trec (PD)	Power down recovery time		5			ms

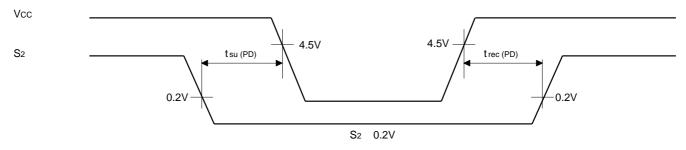
(3) POWER DOWN CHARACTERISTICS

S₁ control mode



Note 9: On the power down mode by controlling $\overline{S_1}$, the input level of S_2 must be S_2 Vcc - 0.2V or S_2 0.2V. The other pins(Address,I/O, \overline{WE} , \overline{OE}) can be in high impedance state.

S₂ control mode





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